

8961726 TEXAS INSTR (OPTO)

62C 36593 D

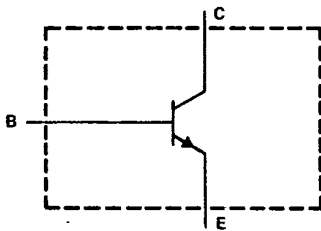
T-33-15

2N5301, 2N5302, 2N5303  
N-P-N SILICON POWER TRANSISTORS

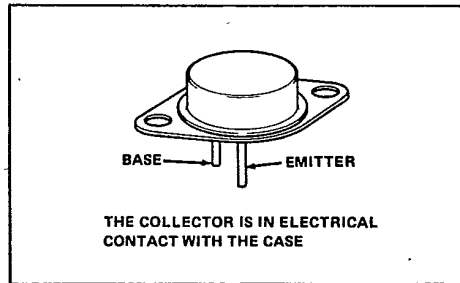
FEBRUARY 1969 - REVISED OCTOBER 1984

- Designed for Complementary Use With 2N4398, 2N4399
- 200 W at 25°C Case Temperature
- 30 A Continuous Collector Current (2N5301, 2N5302)
- 20 A Continuous Collector Current (2N5303)
- 50 A Peak Collector Current
- Min  $f_T$  of 2 MHz at 10 V, 1 A
- Suitable for Use in Power Amplifier and High-Speed Switching Applications

device schematic



TO-3 PACKAGE



2N Devices

absolute maximum ratings at 25° C case temperature (unless otherwise noted)

	2N5301	2N5302	2N5303
*Collector-base voltage	40 V	60 V	80 V
*Collector-emitter voltage ( $V_{BE} = 0$ )	40 V	60 V	80 V
*Emitter-base voltage		5 V	
*Continuous collector current	30 A	30 A	20 A
*Peak collector current (see Note 1)		50 A	
*Continuous base current		7.5 A	
Continuous device dissipation at (or below) 25° C case temperature (see Note 2)	200 W		
Continuous device dissipation at (or below) 25° C free-air temperature (see Note 3)	5 W		
Safe operating region at (or below) 25° C case temperature	See Figures 7 and 8		
*Operating junction and storage temperature range	- 65° C to 200° C		

- NOTES: 1. This value applies for  $t_w \leq 0.3$  ms, duty cycle  $\leq 10\%$ .  
 2. Derate linearly to 200° C case temperature at the rate of 1.14 W/°C.  
 3. Derate linearly to 200° C free-air temperature at the rate of 28.6 mW/°C.

\*JEDEC registered data.

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electrical characteristics at 25°C case temperature (unless otherwise noted)

2N Devices

PARAMETER	TEST CONDITIONS	2N5301			2N5302			2N5303			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
$V_{(BR)CEO}$	$I_C = 0.2 A, I_B = 0,$ See Note 5	40			60			80			V
$I_{CBO}$	$V_{CB} = 40 V, I_E = 0$		1								mA
	$V_{CB} = 60 V, I_E = 0$				1						
	$V_{CB} = 80 V, I_E = 0$							1			
$I_{CEO}$	$V_{CE} = 40 V, I_B = 0$		5								mA
	$V_{CE} = 60 V, I_B = 0$				5						
	$V_{CE} = 80 V, I_B = 0$							5			
$I_{CEV}$	$V_{CE} = 40 V, V_{BE} = -1.5 V$		1								mA
	$V_{CE} = 60 V, V_{BE} = -1.5 V$				1						
	$V_{CE} = 80 V, V_{BE} = -1.5 V$							1			
	$V_{CE} = 40 V, V_{BE} = -1.5 V, T_C = 150^\circ C$		10								
$I_{EBO}$	$V_{EB} = 5 V, I_C = 0$		5		5			5			mA
	$V_{CE} = 2 V, I_C = 1 A$	40			40			40			
$h_{FE}$	$V_{CE} = 2 V, I_C = 10 A$		15		60			15		60	
	$V_{CE} = 2 V, I_C = 15 A$										
	$V_{CE} = 2 V, I_C = 20 A$							5			
	$V_{CE} = 2 V, I_C = 30 A$		5		5						
	$V_{CE} = 2 V, I_C = 10 A$										
$V_{BE}$	$I_B = 1 A, I_C = 10 A$		1.7		1.7					1.7	V
	$I_B = 1.5 A, I_C = 15 A$		1.8		1.8					2	
	$I_B = 2 A, I_C = 20 A$		2.5		2.5						
	$I_B = 4 A, I_C = 20 A$									2.5	
	$V_{CE} = 2 V, I_C = 10 A$									1.5	
	$V_{CE} = 2 V, I_C = 15 A$		1.7		1.7						
	$V_{CE} = 4 V, I_C = 20 A$									2.5	
$V_{CE(sat)}$	$I_B = 1 A, I_C = 10 A$		0.75		0.75					1	V
	$I_B = 1.5 A, I_C = 15 A$									1.5	
	$I_B = 2 A, I_C = 20 A$		2		2						
	$I_B = 4 A, I_C = 20 A$									2	
	$I_B = 6 A, I_C = 30 A$		3		3						
$h_{fe}$	$V_{CE} = 10 V, I_C = 1 A, f = 1 kHz$	40			40			40			
$ h_{fe} $	$V_{CE} = 10 V, I_C = 1 A, f = 1 MHz$	2			2			2			

NOTES: 4. These parameters must be measured using pulse techniques,  $t_w = 300 \mu s$ , duty cycle  $\leq 2\%$ .  
5. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

thermal characteristics

PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JC}$		0.875		$^\circ C/W$
$R_{\theta JA}$		35		$^\circ C/W$

resistive-load switching characteristics at 25°C case temperature

PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	UNIT
$t_r$	$I_C = 10 A, I_{B1} = 1 A, V_{BE(off)} = -2 V,$ $R_L = 3 \Omega,$ See Figure 1			1	$\mu s$
$t_s$	$I_C = 10 A, I_{B1} = 1 A, I_{B2} = -1 A$			2	$\mu s$
$t_f$	$R_L = 3 \Omega,$ See Figure 2			1	$\mu s$

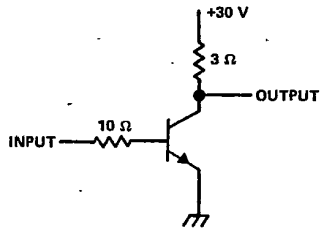
† Voltage and current values shown are nominal, exact values vary slightly with transistor parameters.

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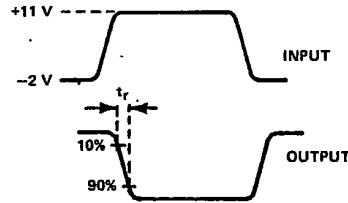
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2N5301, 2N5302, 2N5303  
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PARAMETER MEASUREMENT INFORMATION

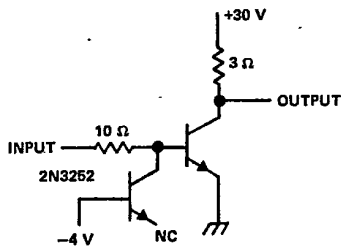


TEST CIRCUIT

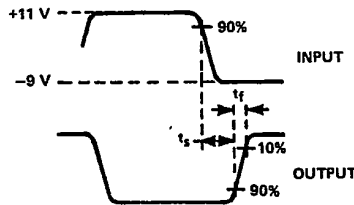


VOLTAGE WAVEFORMS

FIGURE 1. RESISTIVE-LOAD SWITCHING - RISE TIME



TEST CIRCUIT



VOLTAGE WAVEFORMS

FIGURE 2. RESISTIVE-LOAD SWITCHING - STORAGE AND FALL TIMES

- NOTES: A. The input waveforms are supplied by a generator with the following characteristics:  $t_r \leq 20$  ns,  $t_f \leq 20$  ns,  $Z_{out} = 50 \Omega$ ,  $t_w = 10 \mu s$  to  $100 \mu s$ , duty cycle  $\leq 2\%$ .  
 B. Waveforms are monitored on an oscilloscope with the following characteristics:  $t_r \leq 20$  ns,  $R_{in} \geq 10$  k $\Omega$ ,  $C_{in} \leq 11.5$  pF.  
 C. Resistors must be noninductive types.  
 D. The d-c power supplies may require additional bypassing in order to minimize ringing.

2  
2N Devices

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TYPICAL CHARACTERISTICS

2N Devices

2N5301, 2N5302  
STATIC FORWARD CURRENT TRANSFER RATIO  
vs  
COLLECTOR CURRENT

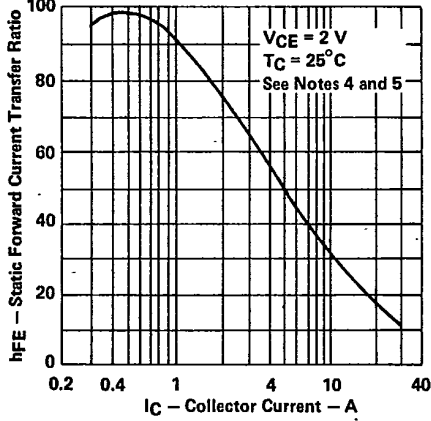


FIGURE 3

2N5303  
STATIC FORWARD CURRENT TRANSFER RATIO  
vs  
COLLECTOR CURRENT

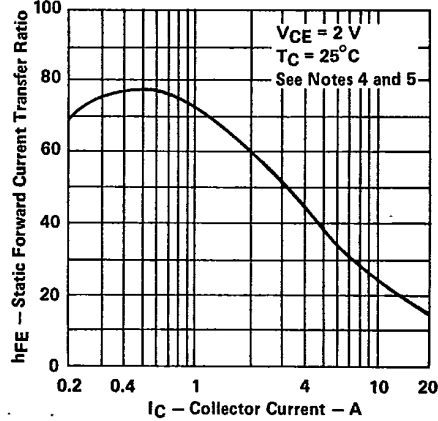


FIGURE 4

BASE-EMITTER VOLTAGE  
vs  
COLLECTOR CURRENT

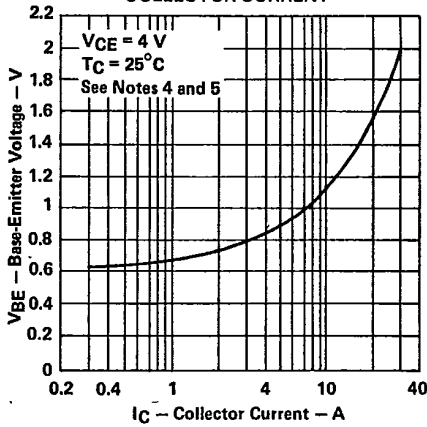


FIGURE 5

COLLECTOR-EMITTER SATURATION VOLTAGE  
vs  
COLLECTOR CURRENT

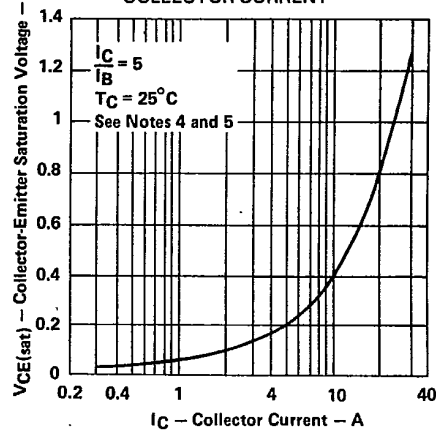


FIGURE 6

NOTES: 4. These parameters must be measured using pulse techniques,  $t_w = 300 \mu s$ , duty cycle  $< 2\%$ .  
5. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

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MAXIMUM SAFE OPERATING AREA

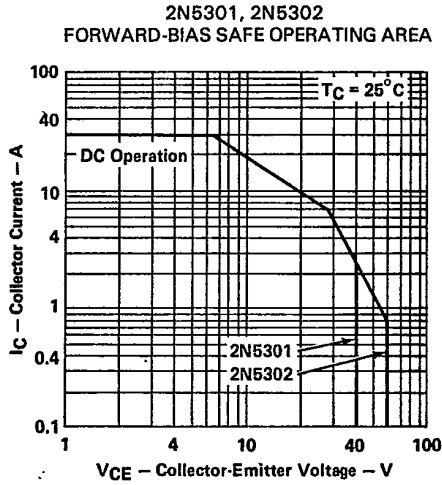


FIGURE 7

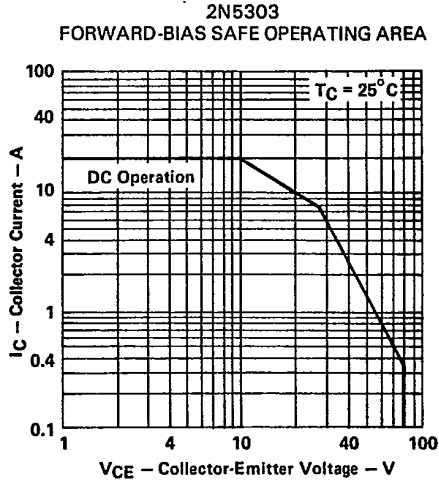


FIGURE 8



2N Devices

THERMAL INFORMATION

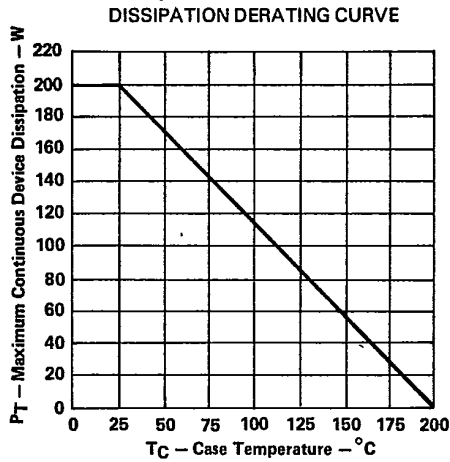


FIGURE 9

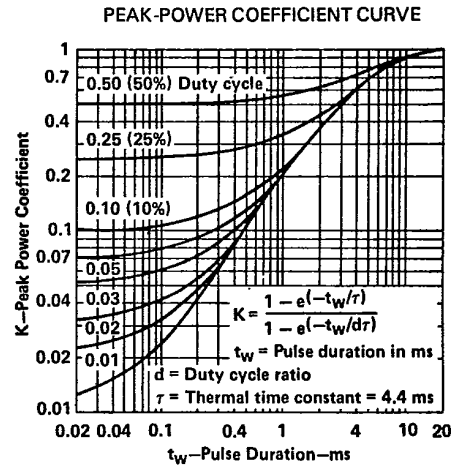


FIGURE 10